SCAS517C - JUNE 1995 - REVISED OCTOBER 2002

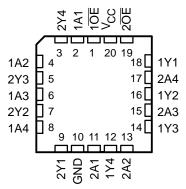
- 4.5-V to 5.5-V V_{CC} Operation
- Inputs Accept Voltages to 5.5 V

SN54ACT244 . . . J OR W PACKAGE SN74ACT244 . . . DB, DW, N, NS, OR PW PACKAGE (TOP VIEW)

1 OE	1	\bigcup_{z}	20] v _{cc}
1A1	2	1	9	2 <u>OE</u>
2Y4	3	1	8] 1Y1
1A2	4	1	7] 2A4
2Y3	5	1	6] 1Y2
1A3	6	1	5	2A3
2Y2	7	1	4] 1Y3
1A4	8	1	3] 2A2
2Y1	9	1	2] 1Y4
GND	10	1	11	2A1

- Max t_{pd} of 9.5 ns at 5 V
- Inputs Are TTL Compatible

SN54ACT244 . . . FK PACKAGE (TOP VIEW)



description/ordering information

These octal buffers/drivers are designed specifically to improve the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters.

The 'ACT244 devices are organized as two 4-bit buffers/drivers with separate output-enable (\overline{OE}) inputs. When \overline{OE} is low, the device passes noninverted data from the A inputs to the Y outputs. When \overline{OE} is high, the outputs are in the high-impedance state.

To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

ORDERING INFORMATION

TA	PACKAGET		ORDERABLE PART NUMBER	TOP-SIDE MARKING	
	PDIP – N	Tube	SN74ACT244N	SN74ACT244N	
	SOIC - DW	Tube	SN74ACT244DW	ACT244	
-40°C to 85°C	30IC - DW	Tape and reel	SN74ACT244DWR	AC1244	
	SOP - NS	Tape and reel	SN74ACT244NSR	ACT244	
	SSOP – DB	Tape and reel	SN74ACT244DBR	AD244	
	TSSOP – PW	Tape and reel	SN74ACT244PWR	AD244	
	CDIP – J	Tube	SNJ54ACT244J	SNJ54ACT244J	
–55°C to 125°C	CFP – W	Tube	SNJ54ACT244W	SNJ54ACT244W	
	LCCC - FK	Tube	SNJ54ACT24FK	SNJ54ACT244FK	

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



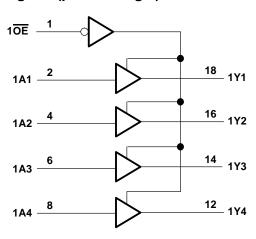
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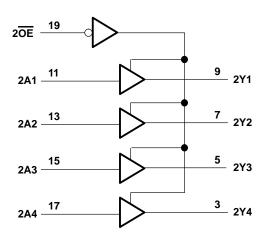


FUNCTION TABLE (each buffer)

INPU	JTS	OUTPUT
OE	Α	Y
L	Н	Н
L	L	L
Н	Χ	Z

logic diagram (positive logic)





absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}		
Input voltage range, V _I (see Note 1)		$0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Output voltage range, VO (see Note 1)		$0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$).		
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CO}$	c)	±20 mA
Continuous output current, $I_O(V_O = 0 \text{ to } V_{CC})$	·····	±50 mA
Continuous current through V _{CC} or GND		±200 mA
Package thermal impedance, θ _{JA} (see Note 2)	: DB package	70°C/W
	DW package	58°C/W
	N package	69°C/W
	NS package	60°C/W
	PW package	83°C/W
Storage temperature range, T _{stg}		–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51-7.



recommended operating conditions (see Note 3)

		SN54ACT244		SN74A	UNIT	
		MIN	MAX	MIN	MAX	UNII
Vcc	Supply voltage	4.5	5.5	4.5	5.5	V
VIH	High-level input voltage	2		2		V
VIL	Low-level input voltage		0.8		0.8	V
٧ _I	Input voltage	0	VCC	0	VCC	V
٧o	Output voltage	0	Vcc	0	VCC	V
ІОН	High-level output current		-24		-24	mA
l _{OL}	Low-level output current		24		24	mA
Δt/Δν	Input transition rise or fall rate		8		8	ns/V
TA	Operating free-air temperature	-55	125	-40	85	°C

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETER	TEST COMPLTIONS		T	A = 25°C	;	SN54A	CT244	SN74ACT244		LINUT
PARAMETER	TEST CONDITIONS	VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
	Jan = 50 u A	4.5 V	4.4	4.49		4.4		4.4		
	$I_{OH} = -50 \mu\text{A}$	5.5 V	5.4	5.49		5.4		5.4		
Vou		4.5 V	3.86			3.7		3.76		V
VOH	I _{OH} = -24 mA	5.5 V	4.86			4.7		4.76		V
	I _{OH} = -50 mA [†]	5.5 V				3.85				
	$I_{OH} = -75 \text{ mA}^{\dagger}$	5.5 V						3.85		
	L 50A	4.5 V		0.001	0.1		0.1		0.1	٧
	$I_{OL} = 50 \mu\text{A}$	5.5 V		0.001	0.1		0.1		0.1	
\/a.	la. 24 mA	4.5 V			0.36		0.5		0.44	
VOL	I _{OL} = 24 mA	5.5 V			0.36		0.5		0.44	
	$I_{OL} = 50 \text{ mA}^{\dagger}$	5.5 V					1.65			
	$I_{OL} = 75 \text{ mA}^{\dagger}$	5.5 V							1.65	
loz	$V_O = V_{CC}$ or GND	5.5 V			±0.25		±5		±2.5	μΑ
lį	V _I = V _{CC} or GND	5.5 V			±0.1		±1		±1	μΑ
Icc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			4		80		40	μΑ
ΔI _{CC} ‡	One input at 3.4 V, Other inputs at GND or V _{CC}	5.5 V		0.6			1.6		1.5	mA
C _i	$V_I = V_{CC}$ or GND	5 V		2.5						pF
Co	V _I = V _{CC} or GND	5 V		8						pF

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 2 ms.



[‡] This is the increase in supply current for each input that is at one of the specified TTL voltage levels, rather than 0 V or VCC.

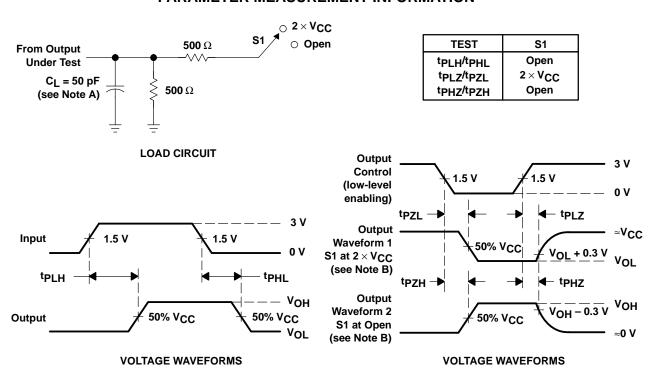
switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	FROM TO		T _A = 25°C		SN54ACT244		SN74ACT244		UNIT
PARAMETER (II	(INPUT)	(INPUT) (OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
t _{PLH}	А	Y	2	6.5	9	1	10	1.5	10	nc
^t PHL			2	7	9	1	10	1.5	10	ns
^t PZH	ŌĒ	Y	1.5	7	8.5	1	9.5	1	9.5	no
t _{PZL}			2	7	9.5	1	11	1.5	10.5	ns
^t PHZ	OE Y	V	2	8	9.5	1	11	1.5	10.5	no
^t PLZ		2.5	7.5	10	1	11.5	2	10.5	ns	

operating characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

PARAMETER		TEST CO	TYP	UNIT	
C _{pd}	Power dissipation capacitance per buffer/driver	$C_L = 50 pF$,	f = 1 MHz	45	pF

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_I includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50~\Omega$, $t_f \leq$ 2.5 ns, $t_f \leq$ 2.5 ns.
- D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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